Figure 1

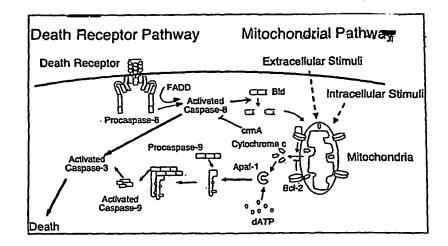
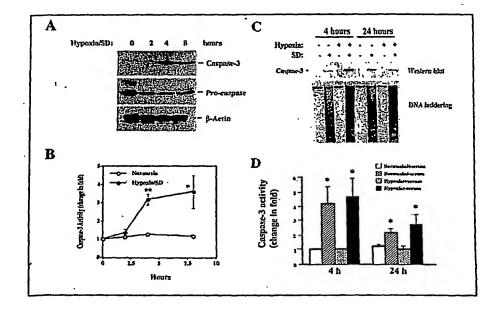


Figure 2



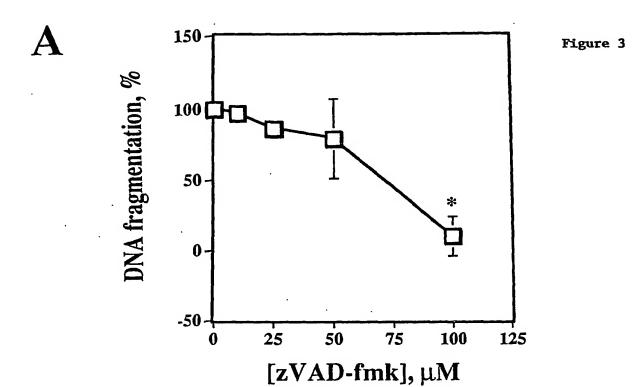


Figure 3C

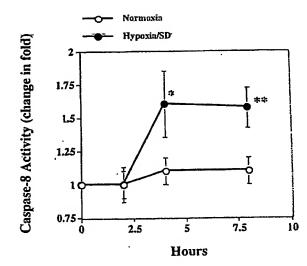
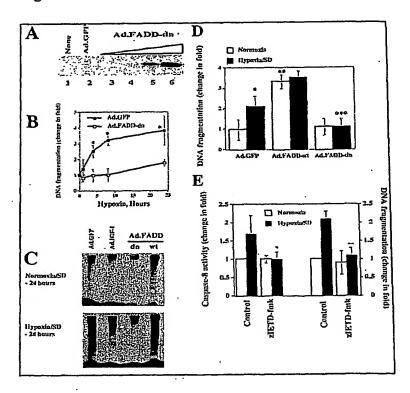


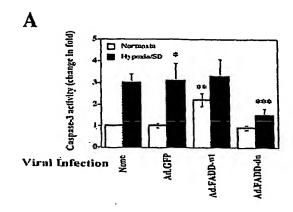
Figure 4



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·Figure 5

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 $\mathbf{B}$ 

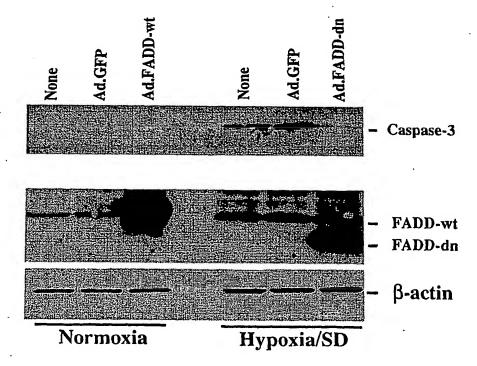


Figure 6

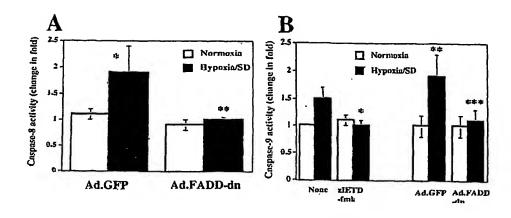
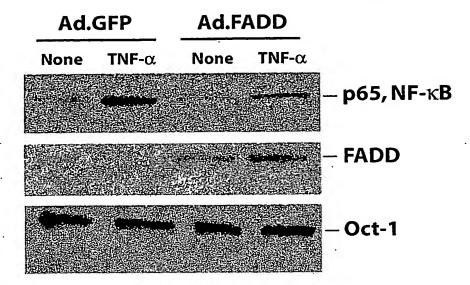


Figure 7

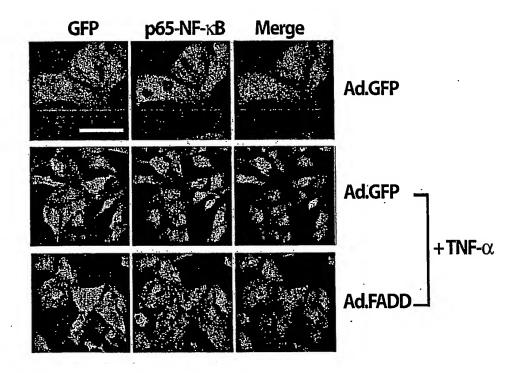


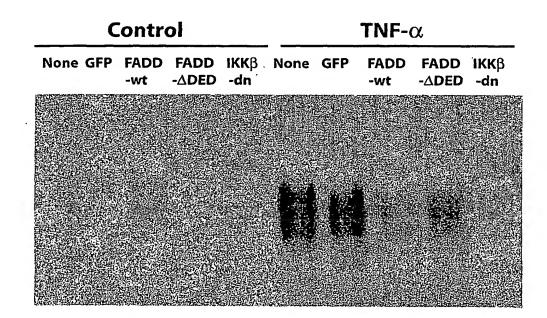
A

#### FIGURE 8



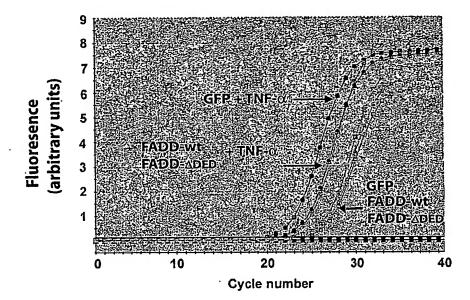
B



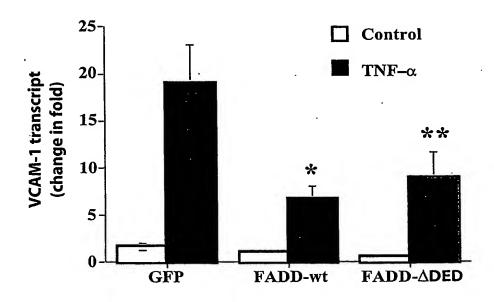


D

## FIGURE 8

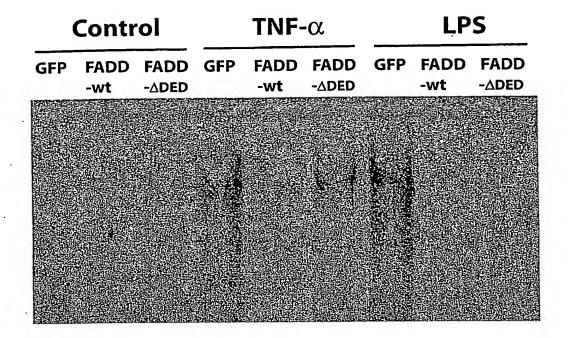


E

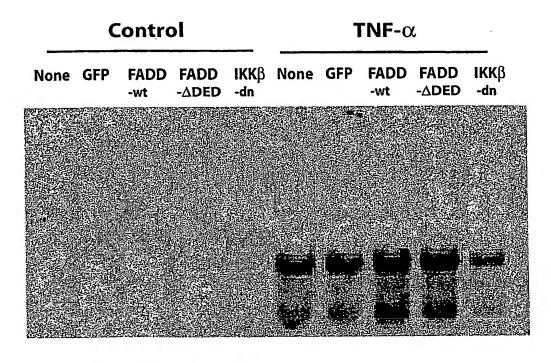


A

### FIGURE 9

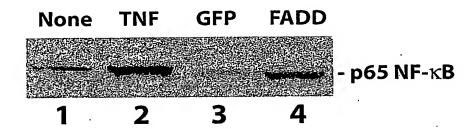


В

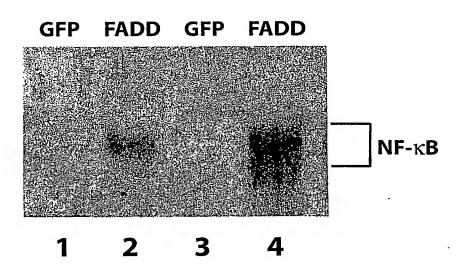


### FIGURE 9

C

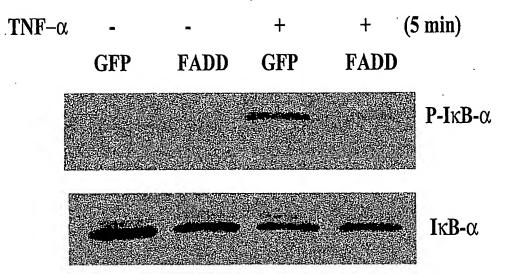


D



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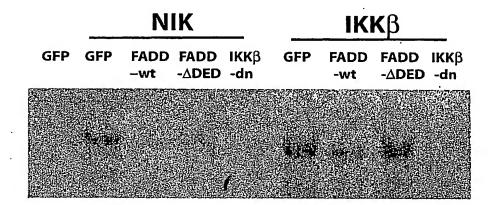


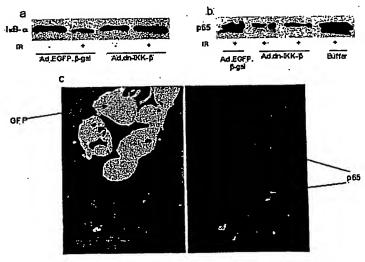
### FIGURE 11

A

	ΙΚΚβ		NIK	
	FADD	GFP	FADD	GFP
P-I $\kappa$ B- $\alpha$				
Р-ІККВ				
<b>ІКК</b> В				MATERIAL NO.
FADD-wt				

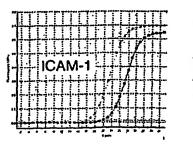
B

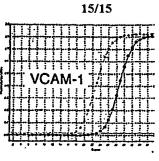




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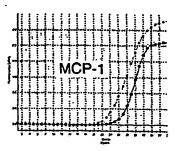


FIGURE 13

#### FIGURE 14

